

Notice of References Cited	Application/Control No. 10/600,885		Applicant(s)/Patent Under Reexamination BALLAGH ET AL.	
	Examiner Kandasamy Thangavelu		Art Unit 2123	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0117274	06-2006	Tseng et al.	716/001
*	B	US-2003/0105620	06-2003	Bowen, Matt	703/22
*	C	US-6,850,092	02-2005	Chelcea et al.	326/93
*	D	US-2004/0236556	11-2004	Lin, Sharon Sheau-Pyng	703/014
*	E	US-2003/0115564	06-2003	Chang et al.	716/8
*	F	US-2002/0083420	06-2002	Zammit et al.	717/135
*	G	US-6,449,284	09-2002	Hagirahim, Hassan	370/466
*	H	US-2002/0194581	12-2002	Keener, Bryan F.	717/136
*	I	US-2004/0181385	09-2004	Milne et al.	703/014
*	J	US-6,907,584	06-2005	Milne et al.	716/1
*	K	US-2002/0177990	11-2002	Sample, Stephen P.	703/28
*	L	US-6,937,973	08-2005	Panesar, Gajinder Singh	703/21
*	M	US-2003/0070070	04-2003	Yeager et al.	713/157

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.